

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10526427	TAKAGAWA ET AL.
	Examiner	Art Unit
	Hevey, John A	1793

SEARCHED			
Class	Subclass	Date	Examiner
252	62.56-62.59, 62.62-62.63	10/11/2007, 4/8/2008	jah

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST see search history	10/11/2007, 4/8/2008	jah	
PALM inventor search	10/11/2007	jah	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner